

ELECTRONIC CORRELATIONS AND INELASTIC SCATTERING IN TRANSPORT THROUGH MOLECULES

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In the “standard approach” to first-principles simulations of quantum transport in nano-scale junctions, the electrons are modelled as non-interacting particles moving in the effective potential obtained from a Density Functional Theory (DFT) calculation. While DFT, in principle, yields the exact groundstate energy of the interacting system, there is no guarantee that it provides a good description of electrical current. In this talk I will discuss our recent work on including (i) inelastic electron-vibron scattering and (ii) electronic correlations in quantum transport calculations. In both cases (i) and (ii) we include the interactions as self-energies (first Born and GW approximations, respectively) evaluated self-consistently within the Keldysh non-equilibrium Green’s function formalism. In one application, we find that inelastic scattering on the longitudinal (transverse) molecular vibrations of a metal-H₂-metal junction leads to negative (positive) steps in the conductance. In a second application, we investigate the role of electronic correlations in nonequilibrium transport using a generic two-level model of a molecular junction. In equilibrium, dynamic screening effects (image charge effects) lead to a characteristic renormalization of the quasi-particle (QP) HOMO-LUMO gap. As the bias is raised, the phase-space for QP scattering increases and this leads to significant reduction of the lifetime of the molecular levels. Both effects have a large impact on the IV curve of the model junction.

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